

این دیتاشیت توسط توکل الکترونیک تهیه و ارائه شده است.
جهت مشاهده قیمت، موجودی و ثبت سفارش این قطعه به وبسایت توکل الکترونیک مراجعه فرمایید.



مشاهده قیمت و خرید
برای خرید و مشاهده سایر محصولات کلیک کنید



Advanced Power MOSFET

SSP5N90A

FEATURES

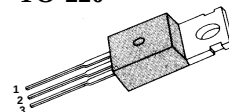
- Avalanche Rugged Technology
- Rugged Gate Oxide Technology
- Lower Input Capacitance
- Improved Gate Charge
- Extended Safe Operating Area
- Lower Leakage Current : 25 μ A (Max.) @ $V_{DS} = 900V$
- Low $R_{DS(ON)}$: 2.300 Ω (Typ.)

$$BV_{DSS} = 900 V$$

$$R_{DS(on)} = 2.9 \Omega$$

$$I_D = 5 A$$

TO-220



1. Gate 2. Drain 3. Source

Absolute Maximum Ratings

Symbol	Characteristic	Value	Units
V_{DSS}	Drain-to-Source Voltage	900	V
I_D	Continuous Drain Current ($T_C=25^\circ C$)	5	A
	Continuous Drain Current ($T_C=100^\circ C$)	3.2	
I_{DM}	Drain Current-Pulsed ①	20	A
V_{GS}	Gate-to-Source Voltage	± 30	V
E_{AS}	Single Pulsed Avalanche Energy ②	529	mJ
I_{AR}	Avalanche Current ①	5	A
E_{AR}	Repetitive Avalanche Energy ①	14	mJ
dv/dt	Peak Diode Recovery dv/dt ③	1.5	V/ns
P_D	Total Power Dissipation ($T_C=25^\circ C$)	140	W
	Linear Derating Factor	1.12	W/ $^\circ C$
T_J, T_{STG}	Operating Junction and Storage Temperature Range	- 55 to +150	$^\circ C$
T_L	Maximum Lead Temp. for Soldering Purposes, 1/8 " from case for 5-seconds	300	

Thermal Resistance

Symbol	Characteristic	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case	--	0.89	$^\circ C / W$
$R_{\theta CS}$	Case-to-Sink	0.5	--	
$R_{\theta JA}$	Junction-to-Ambient	--	62.5	

Electrical Characteristics ($T_C=25\text{ }^{\circ}\text{C}$ unless otherwise specified)

Symbol	Characteristic	Min.	Typ.	Max.	Units	Test Condition
BV_{DSS}	Drain-Source Breakdown Voltage	900	--	--	V	$V_{GS}=0V, I_D=250\mu A$
$\Delta BV/\Delta T_J$	Breakdown Voltage Temp. Coeff.	--	1.14	--	V/ $^{\circ}\text{C}$	$I_D=250\mu A$ See Fig 7
$V_{GS(th)}$	Gate Threshold Voltage	2.0	--	3.5	V	$V_{DS}=5V, I_D=250\mu A$
I_{GSS}	Gate-Source Leakage , Forward	--	--	100	nA	$V_{GS}=30V$
	Gate-Source Leakage , Reverse	--	--	-100		$V_{GS}=-30V$
I_{DSS}	Drain-to-Source Leakage Current	--	--	25	μA	$V_{DS}=900V$
		--	--	250		$V_{DS}=720V, T_C=125\text{ }^{\circ}\text{C}$
$R_{DS(on)}$	Static Drain-Source On-State Resistance	--	--	2.9	Ω	$V_{GS}=10V, I_D=2.5A$ ④*
g_{fs}	Forward Transconductance	--	4.0	--	Ω	$V_{DS}=50V, I_D=2.5A$ ④
C_{iss}	Input Capacitance	--	1110	1440	pF	$V_{GS}=0V, V_{DS}=25V, f=1\text{MHz}$ See Fig 5
C_{oss}	Output Capacitance	--	105	125		
C_{rss}	Reverse Transfer Capacitance	--	43	50		
$t_{d(on)}$	Turn-On Delay Time	--	21	50	ns	$V_{DD}=450V, I_D=5A,$ $R_G=13.6\text{ }\Omega$ See Fig 13 ④ ⑤
t_r	Rise Time	--	39	90		
$t_{d(off)}$	Turn-Off Delay Time	--	94	200		
t_f	Fall Time	--	32	75		
Q_g	Total Gate Charge	--	54	70	nC	$V_{DS}=720V, V_{GS}=10V,$ $I_D=5A$ See Fig 6 & Fig 12 ④ ⑤
Q_{gs}	Gate-Source Charge	--	9.0	--		
Q_{gd}	Gate-Drain("Miller") Charge	--	25.0	--		

Source-Drain Diode Ratings and Characteristics

Symbol	Characteristic	Min.	Typ.	Max.	Units	Test Condition
I_S	Continuous Source Current	--	--	5	A	Integral reverse pn-diode in the MOSFET
I_{SM}	Pulsed-Source Current ①	--	--	20		
V_{SD}	Diode Forward Voltage ④	--	--	1.4	V	$T_J=25^{\circ}\text{C}, I_S=5A, V_{GS}=0V$
t_{rr}	Reverse Recovery Time	--	540	--	ns	$T_J=25^{\circ}\text{C}, I_F=5A$
Q_{rr}	Reverse Recovery Charge	--	5.62	--	μC	$di_F/dt=100A/\mu s$ ④

Notes ;

- ① Repetitive Rating : Pulse Width Limited by Maximum Junction Temperature
- ② $L=40\text{mH}, I_{AS}=5A, V_{DD}=50V, R_G=27\Omega$, Starting $T_J=25\text{ }^{\circ}\text{C}$
- ③ $I_{SD} \leq 5A, di/dt \leq 120A/\mu s, V_{DD} \leq BV_{DSS}$, Starting $T_J=25\text{ }^{\circ}\text{C}$
- ④ Pulse Test : Pulse Width = 250 μs , Duty Cycle $\leq 2\%$
- ⑤ Essentially Independent of Operating Temperature